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# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









# **IGBT**

## FMG2G200US60

## **Molding Type Module**

## **General Description**

Fairchild IGBT Power Module provides low conduction and switching losses as well as short circuit ruggedness. It's designed for the applications such as motor control, uninterrupted power supplies (UPS) and general inverters where short-circuit ruggedness is required.

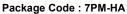
## **Features**

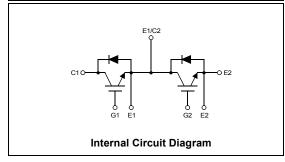
- Short Circuit Rated Time; 10us @  $T_C = 100$ °C,  $V_{GE} = 15$ V
- · High Speed Switching
- Low Saturation Voltage : V<sub>CE</sub>(sat) = 2.1 V @ I<sub>C</sub> = 200A
- · High Input Impedance
- Fast & Soft Anti-Parallel FWD
- · UL Certified No.E209204

## **Application**

- AC & DC Motor Controls
- · General Purpose Inverters
- Robotics
- · Servo Controls
- UPS







## **Absolute Maximum Ratings** T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Description		FMG2G200US60	Units
V <sub>CES</sub>	Collector-Emitter Voltage		600	V
V <sub>GES</sub>	Gate-Emitter Voltage		± 20	V
I <sub>C</sub>	Collector Current	@ T <sub>C</sub> = 80°C	200	Α
I <sub>CM (1)</sub>	Pulsed Collector Current		400	Α
I <sub>F</sub>	Diode Continuous Forward Current	@ T <sub>C</sub> = 80°C	200	Α
I <sub>FM</sub>	Diode Maximum Forward Current		400	Α
P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	695	W
T <sub>SC</sub>	Short Circuit Withstand Time	@ T <sub>C</sub> = 100°C	10	us
T <sub>J</sub>	Operating Junction Temperature	Operating Junction Temperature		°C
T <sub>STG</sub>	Storage Temperature Range	Storage Temperature Range		°C
V <sub>ISO</sub>	Isolation Voltage	@ AC 1minute	2500	V
Mounting Torque	Power Terminal Screw : M5		4.0	N.m
Mounting Torque	Mounting Screw : M6		4.0	N.m

#### Notes

(1) Repetitive rating : Pulse width limited by max. junction temperature

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Cha	racteristics					
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	V <sub>GE</sub> = 0V, I <sub>C</sub> = 250uA	600			V
ΔB <sub>VCES</sub> / ΔΤ <sub>J</sub>	Temperature Coeff. of Breakdown Voltage	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1mA		0.6		V/°C
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
I <sub>GES</sub>	Gate - Emitter Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA

## **On Characteristics**

V <sub>GE(th)</sub>	Gate - Emitter Threshold Voltage	$I_C$ = 200mA, $V_{CE}$ = $V_{GE}$	5.0	6.5	8.5	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage	$I_C = 200A$ , $V_{GE} = 15V$		2.1	2.7	V

## **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			80		ns
t <sub>r</sub>	Rise Time	.,		120		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{CC} = 300 \text{ V, } I_{C} = 200 \text{A,}$		130	-	ns
t <sub>f</sub>	Fall Time	$R_G = 2\Omega$ , $V_{GE} = 15V$ , Inductive Load, $T_C = 25^{\circ}C$		130	250	ns
t <sub>f</sub> E <sub>on</sub>	Turn-On Switching Loss	middelive Load, 1 <sub>C</sub> = 25 C		2.7		mJ
E <sub>off</sub>	Turn-Off Switching Loss			6.0		mJ
t <sub>d(on)</sub>	Turn-On Delay Time			200		ns
t <sub>r</sub>	Rise Time	.,		130		ns
$t_{d(off)}$	Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_C = 200 \text{A},$		170	-	ns
t <sub>f</sub>	Fall Time	$R_G = 2\Omega$ , $V_{GE} = 15V$ , Inductive Load, $T_C = 125$ °C		240		ns
t <sub>f</sub> E <sub>on</sub>	Turn-On Switching Loss	middelive Load, 1 <sub>C</sub> = 123 C		4.4		mJ
E <sub>off</sub>	Turn-Off Switching Loss			10.5	-	mJ
T <sub>sc</sub>	Short Circuit Withstand Time	V <sub>CC</sub> = 300 V, V <sub>GE</sub> = 15V @ T <sub>C</sub> = 100°C	10			us
$Q_g$	Total Gate Charge	V = 200 V L = 200 A		625		nC
Q <sub>ae</sub>	Gate-Emitter Charge	$V_{CE} = 300 \text{ V}, I_{C} = 200 \text{A},$		150		nC
Q <sub>ge</sub> Q <sub>gc</sub>	Gate-Collector Charge	V <sub>GE</sub> = 15V		215		nC

## Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units	
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> = 200A	T <sub>C</sub> = 25°C		1.9	2.8	V	
			T <sub>C</sub> = 100°C		1.8			
A Diada Davarras Dasavarra Tiras	Diada Dayarsa Dagayar, Tima		T <sub>C</sub> = 25°C		90	130		
t <sub>rr</sub>	Diode Reverse Recovery Time		T <sub>C</sub> = 100°C		130		ns	
	Diode Peak Reverse Recovery Current	I <sub>F</sub> = 200A	$T_C = 25^{\circ}C$		19	25	Α	
'rr		Current di / dt = $400 \text{ A/us}$ $T_C = 100^\circ$	T <sub>C</sub> = 100°C		25		_ A	
Q <sub>rr</sub>	Diode Reverse Recovery Charge	Diada Dayaraa Baaayary Charra		T <sub>C</sub> = 25°C		855	1600	200
			T <sub>C</sub> = 100°C		1625		nC	

## **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case (IGBT Part, per 1/2 Module)		0.18	°C/W
$R_{\theta JC}$	Junction-to-Case (DIODE Part, per 1/2 Module)		0.37	°C/W
$R_{\theta JC}$	Case-to-Sink (Conductive grease applied)	0.04		°C/W
Weight	Weight of Module	240		g

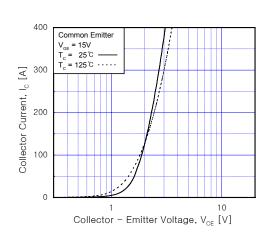


Fig 1. Typical Output Characteristics

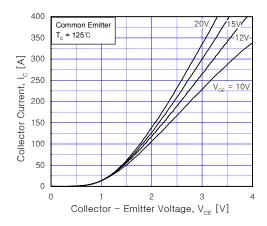


Fig 3. Typical Saturation Voltage Characteristics

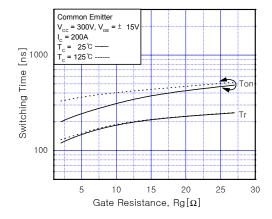


Fig 5. Turn-On Characteristics vs.
Gate Resistance

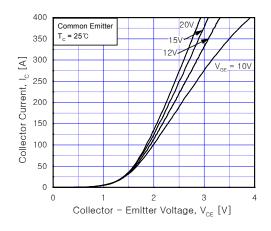


Fig 2. Typical Saturation Voltage Characteristics

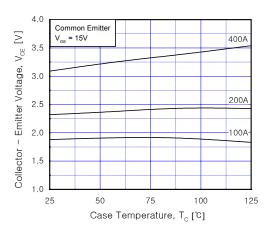


Fig 4. Saturation Voltage vs. Case Temperature at Variant Current Level

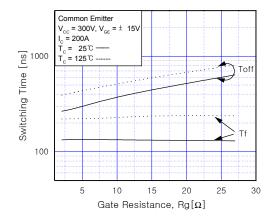


Fig 6. Turn-Off Characteristics vs.
Gate Resistance

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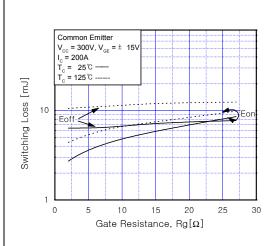


Fig 7. Switching Loss vs. Gate Resistance

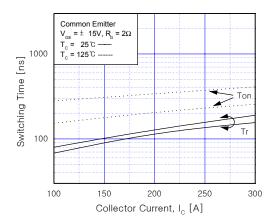


Fig 8. Turn-On Characteristics vs. Collector Current

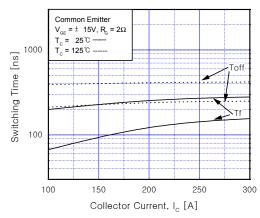


Fig 9. Turn-Off Characteristics vs. Collector Current

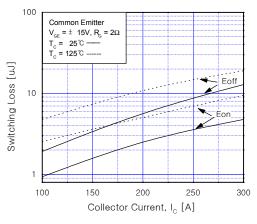


Fig 10. Switching Loss vs. Collector Current

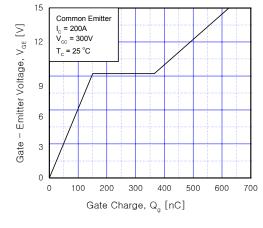


Fig 11. Gate Charge Characteristics

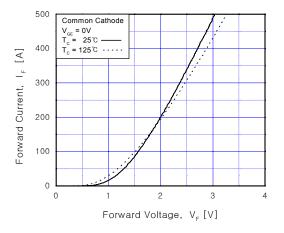


Fig 12. Forward Characteristics(diode)

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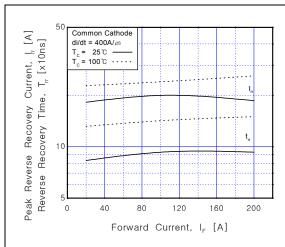
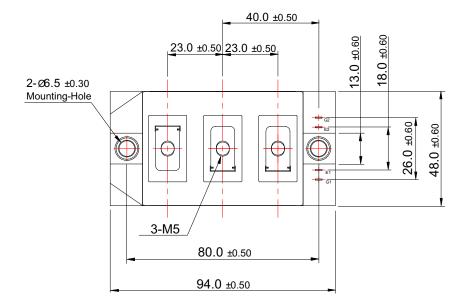
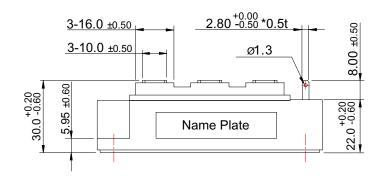


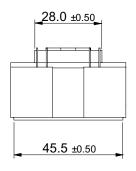
Fig 13. Reverse Recovery Characteristics(diode)

## **Package Dimension**

# 7PM-HA







Dimensions in Millimeters

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